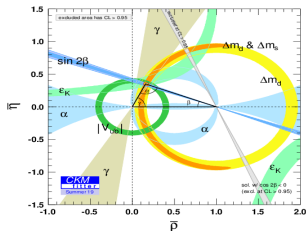# γ analysis update in $B^{\pm} \to (K^+K^-\pi^+\pi^-)_D K^{\pm}$ decays

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Summary of last time

- γ from $B^{\pm} \to DK^{\pm}$, $D \to K^+K^-\pi^+\pi^-$, arXiv:hep-ph/0611272

- Model independent measurement with BESIII strong phase input

- Expected precision from signal-only study: $\Delta\gamma = 12°$

- B candidate selection with BDT

- Currently only Run 2

- Inital mass fits

Summary of analysis procedure

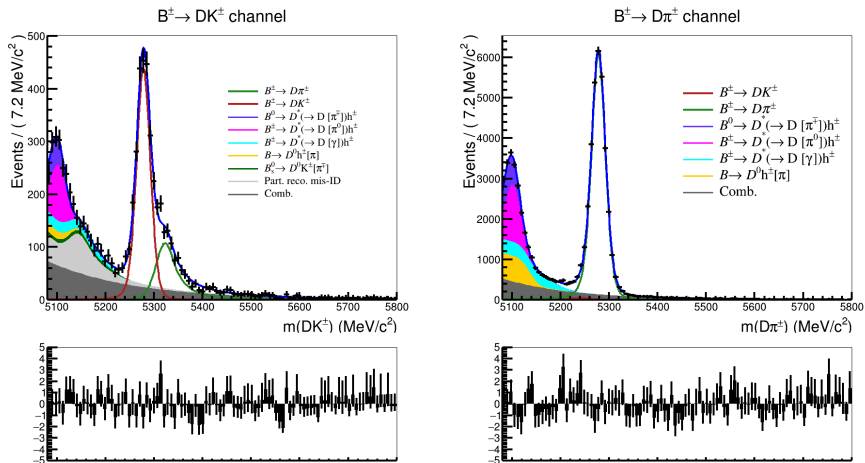1. Perform global fit to fix yields and shapes

2. Separate $B^{\pm}$ candidates by charge and into bins

3. Extract $x_{\pm}$ and $y_{\pm}$ with a simultaneous fit

4. Interpret $x_{\pm}$ and $y_{\pm}$ in terms of γ

CP observables

$$x_{\pm} = r_B^{DK} \cos\left(\delta_B^{DK} \pm \gamma\right), \quad y_{\pm} = r_B^{DK} \sin\left(\delta_B^{DK} \pm \gamma\right)$$

$$x_{\xi}^{D\pi} = \mathrm{Re}(\xi^{D\pi}), \quad y_{\xi}^{D\pi} = \mathrm{Im}(\xi^{D\pi}), \quad \xi^{D\pi} = \frac{r_B^{D\pi}}{r_B^{DK}} e^{i(\delta_B^{D\pi} - \delta_B^{DK})}$$

Outline

Figure 1: Global mass fit (left) $B \to DK$ and (right) $B \to D\pi$

Mis-ID from $D \to K\pi\pi\pi$

- Mis-ID of D daughter $\pi \to K$
- Peaks a much higher D mass
- Much higher branching ratio
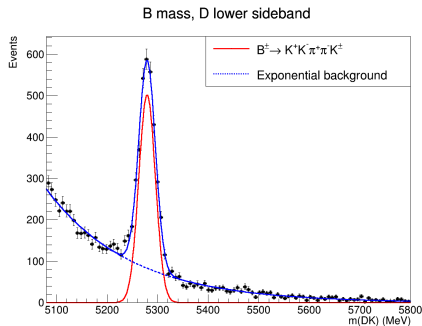- Similar background from $D \to \pi\pi\pi\pi$ is negligible
- Pick cut at 0 for now
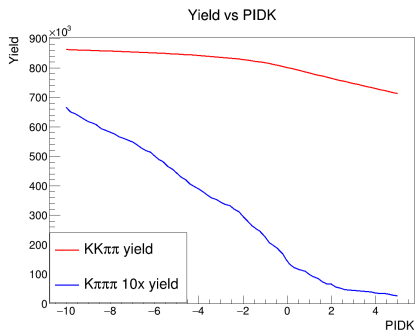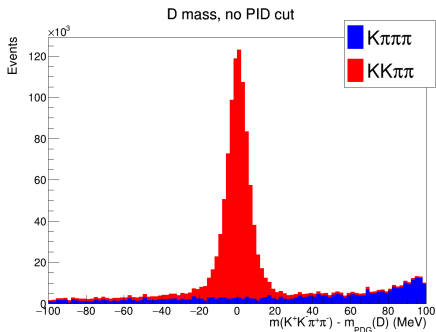
(a) D invariant mass for $KK\pi\pi$ and $K\pi\pi\pi$
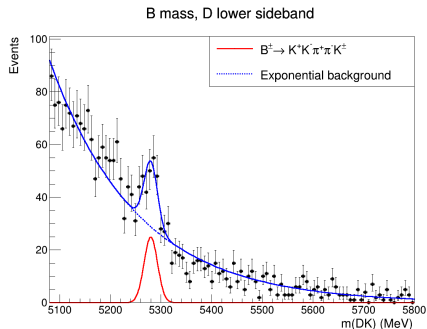
(b) Yield of $KK\pi\pi$ and $K\pi\pi\pi$ vs PIDK

Charmless backgrounds

- $B^{\pm} \to KK\pi\pi h^{\pm}$ background

- Flight significance (FS) cut at 2

- Use D mass sideband $m(D) = [1770\,\text{MeV}, 1820\,\text{MeV}]$

- Train a separate BDT without χ^2_{DTF}

- Overlap between samples with (without) FS cut: 93.1% (90.7%)

Total charmless background yield
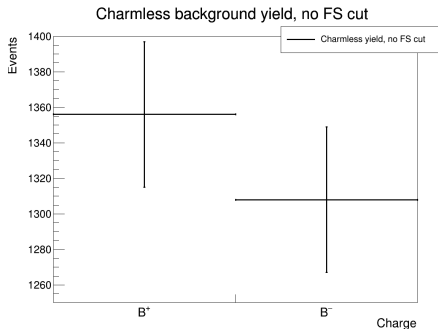

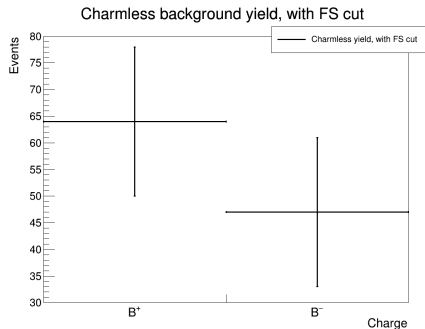**(a)** Without flight significance cut

(b) With flight significance cut
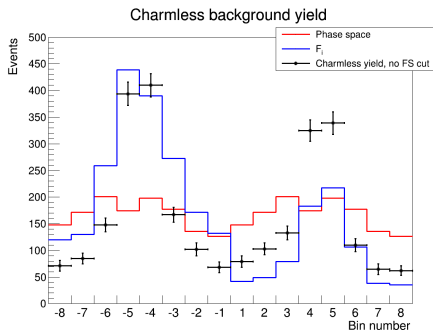
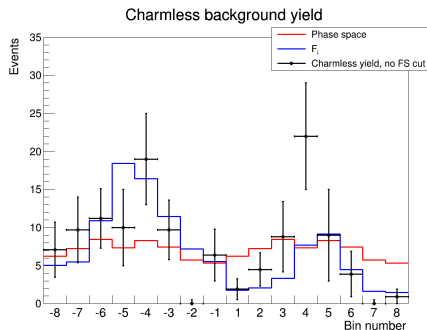**Figure 3:** Charmless background in the D sideband

(a) Without flight significance cut

(b) With flight significance cut

**Figure 4:** Charmless background split by charge

(a) Without flight significance cut

(b) With flight significance cut

Figure 5: Charmless background split by bins

BDT cut optimization

- Current BDT cut: 0.75

- Minimize statistical γ error

- Procedure:
  1. Perform global fit to fix signal and background yields and PDF shapes
  2. Generate 1000 toy datasets using the global fit parameters
  3. Fit for γ
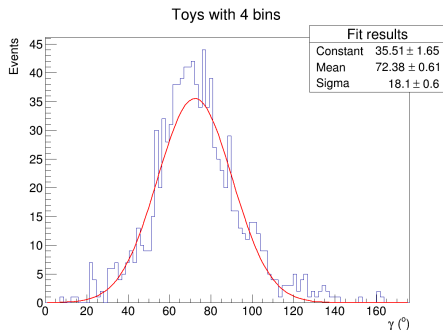 4. Extract expected γ precision from γ distribution of toy datasets

BDT cut optimization
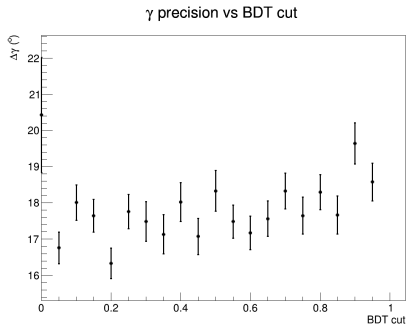
(a) γ precision vs BDT cut for 4 bins

(b) γ precision vs BDT cut for 8 bins
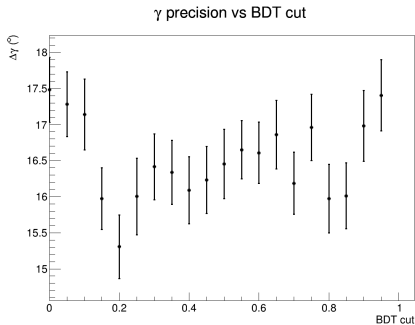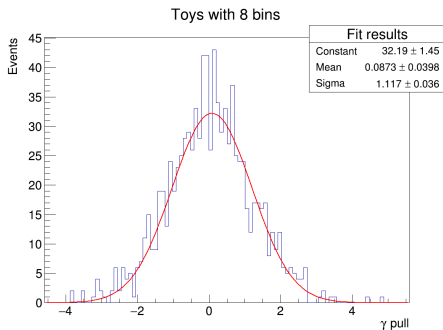
(a) γ from toys

(b) γ pull distribution

Standard toy studies with 8 bins
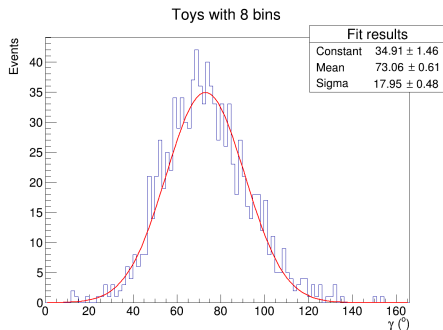
(a) γ from toys

(b) γ pull distribution
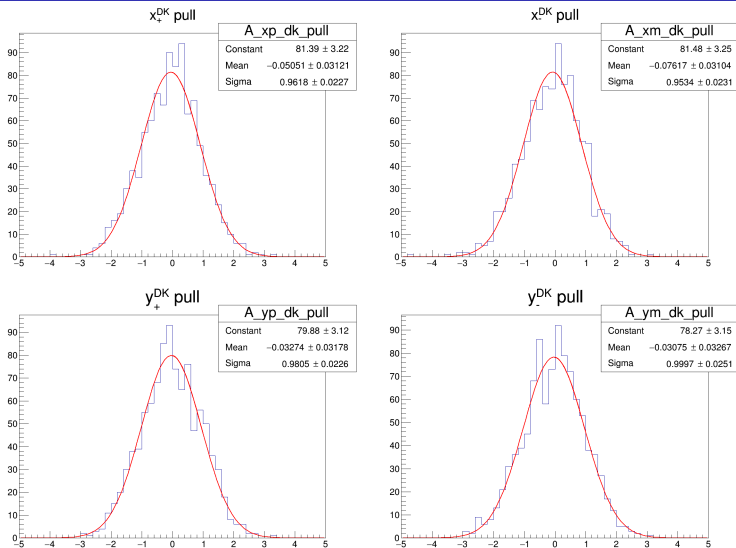
Figure 9: $B \to DK$ CP observable pull distributions
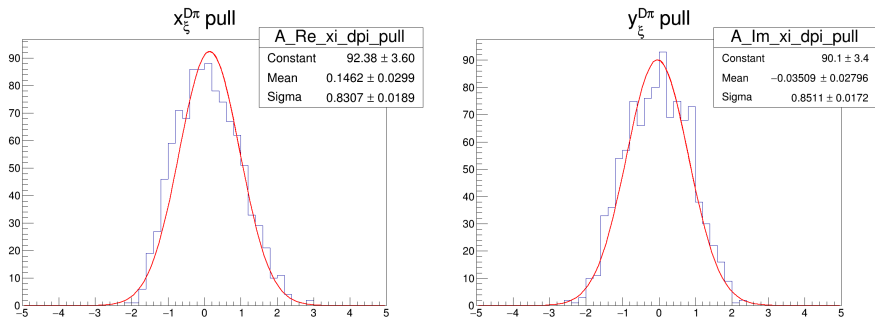
Figure 10: $B \to D\pi$ CP observable pull distributions
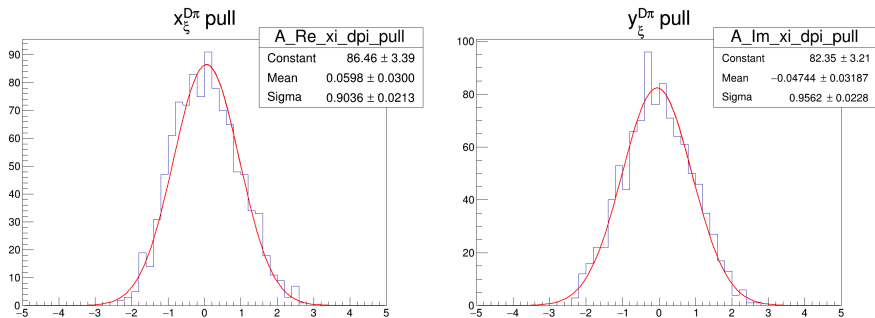
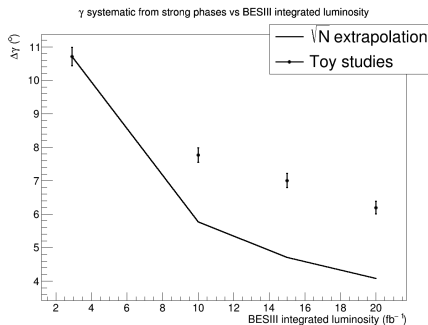**Figure 11:** $B \to D\pi$ CP observable pull distributions
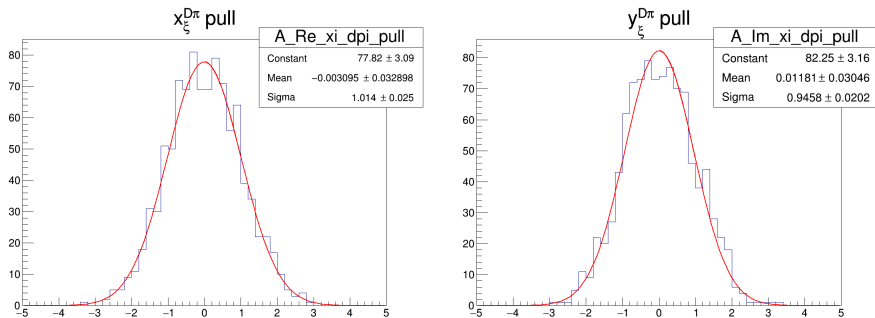
Figure 12: $B \to D\pi$ CP observable pull distributions

Systematics from c_i, s_i
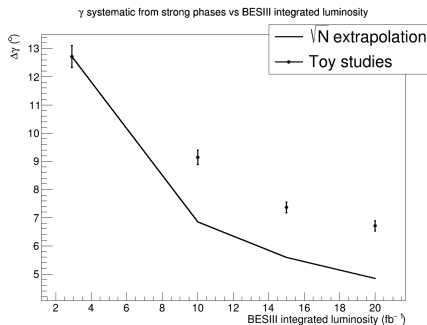
(a) 4 bins

(b) 8 bins

Figure 13: c_i, s_i systematic uncertainty with extrapolated BESIII statistics

Summary and future work

- Summary:
    1. Global mass fit looks promising

    2. $D \to K\pi\pi\pi$ and charmless backgrounds under control

    3. Toy studies show no suspicious behaviour

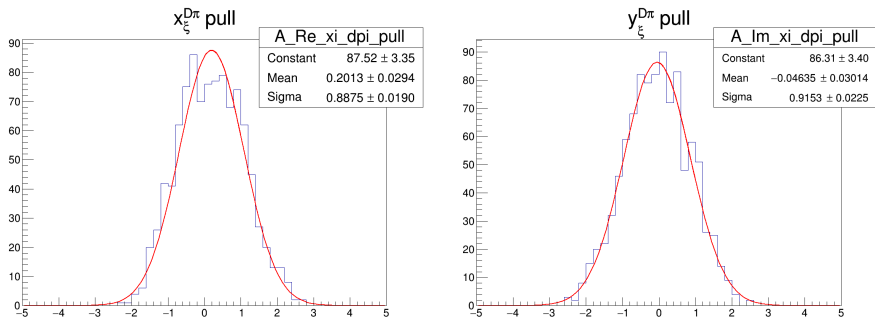   4. Expected c_i and s_i systematics are not too large

- Next steps:
    1. Study semileptonic backgrounds in RapidSim

    2. Recalculate PID efficiencies with PIDCalib

    3. Refit MC signal shapes

    4. Rerun everything with Run 1 (finally!)
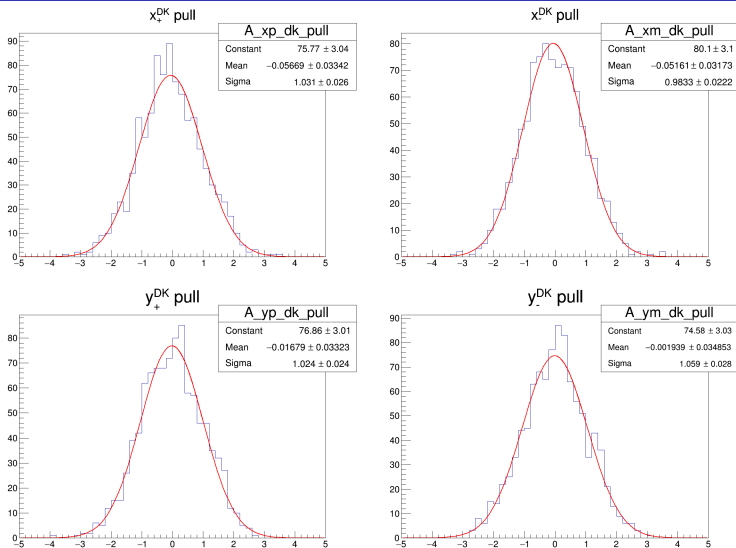
Figure 14: $B \to DK$ CP observable pull distributions

Figure 15: $B \to D\pi$ CP observable pull distributions
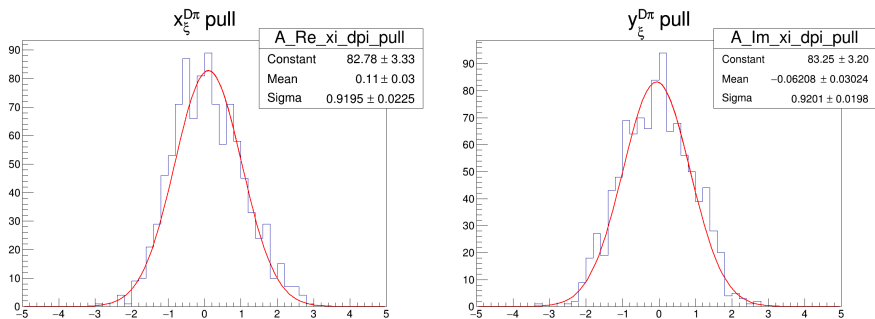
Figure 16: $B \to D\pi$ CP observable pull distributions
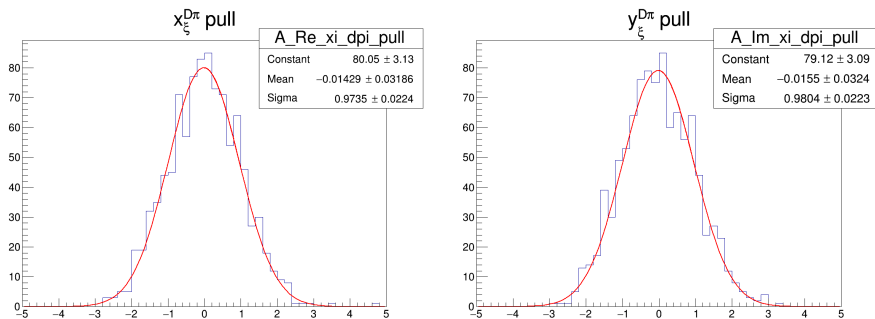
Figure 17: $B \to D\pi$ CP observable pull distributions
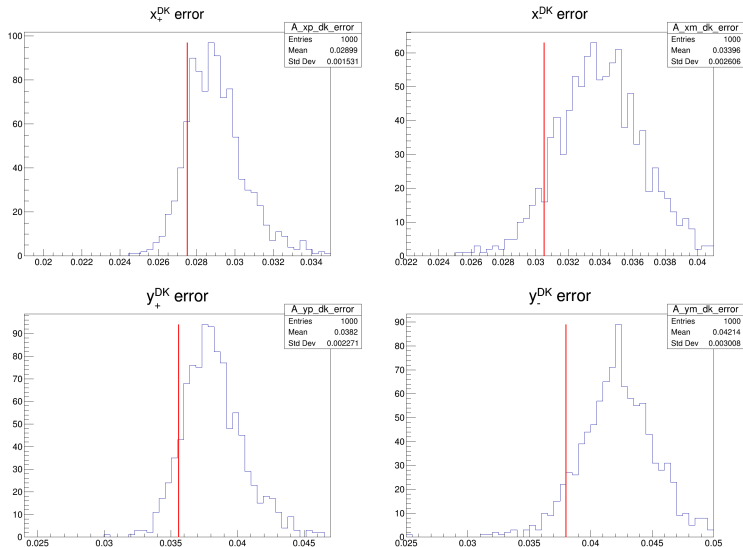
Figure 18: $B \to DK$ CP observable error distributions, red line is data
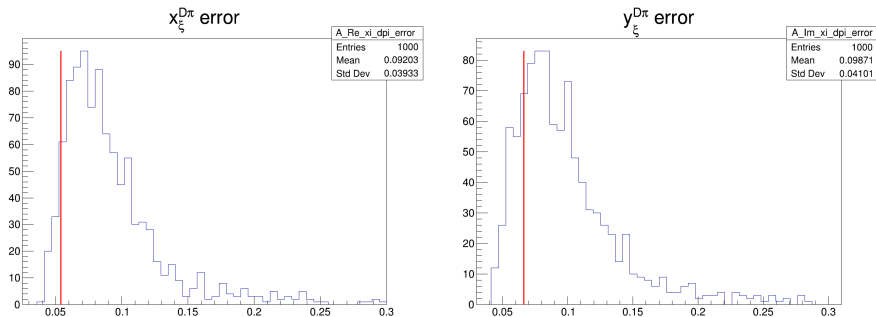
Figure 19: $B \to D\pi$ CP observable error distributions, red line is data
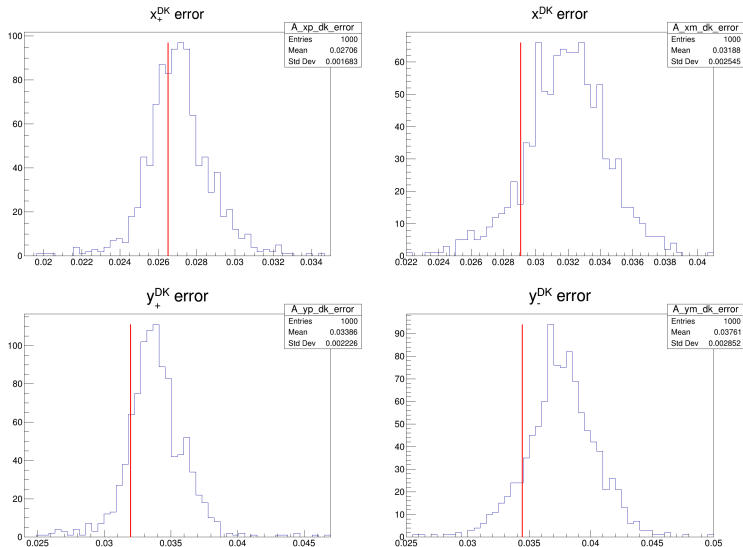
Figure 20: $B \to DK$ CP observable error distributions, red line is data
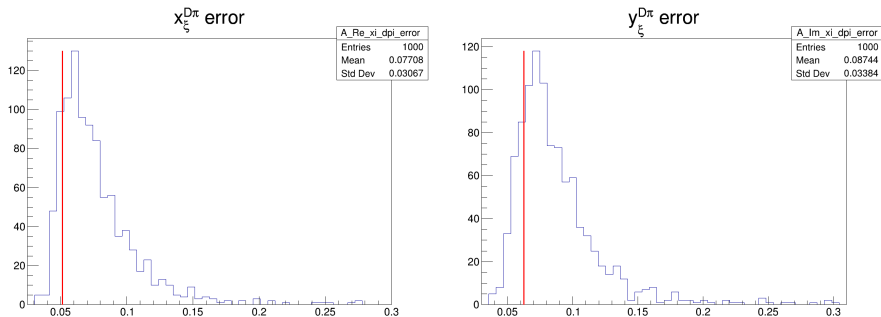
Figure 21: $B \to D\pi$ CP observable error distributions, red line is data

(a) 4 bins

(b) 8 bins

Figure 22: γ error distributions, red line is data